



High-end Power Semiconductor Manufacturer

KP1600A 3000V-3600V Phase Control Thyristor

- High power cycling capability
- Low on-state and switching losses
- Designed for traction and industrial applications



Mean on-state current	I _{TAV}	1600 A		
Repetitive peak off-state voltage	V _{DRM}	3000 – 3600 V		
Repetitive peak reverse voltage	V _{RRM}			
Turn-off time	t _q	500 µs		
V _{DRM} , V _{RRM} , V	3000	3200	3400	3600
Voltage code	30	32	34	36
T _j , °C		-60 – 125		

MAXIMUM ALLOWABLE RATINGS

Symbols and parameters		Units	Values	Test conditions
ON-STATE				
I _{TAV}	Mean on-state current	A	1600	T _c =85 °C, Double side cooled 180° half-sine wave; 50 Hz
I _{TRMS}	RMS on-state current	A	2512	T _c =85 °C, Double side cooled 180° half-sine wave; 50 Hz
I _{TSM}	Surge on-state current	kA	36.0 41.0	180° half-sine wave; 50 Hz (t _p =10 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 µs; di _G /dt≥1 A/µs
			38.0 44.0	180° half-sine wave; 60 Hz (t _p =8.3 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 µs; di _G /dt≥1 A/µs
I ² t	Safety factor	A ² s·10 ³	6480 8405	180° half-sine wave; 50 Hz (t _p =10 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 µs; di _G /dt≥1 A/µs
			5990 8030	180° half-sine wave; 60 Hz (t _p =8.3 ms); single pulse; V _D =V _R =0 V; Gate pulse: I _G =2 A; t _{GP} =50 µs; di _G /dt≥1 A/µs
BLOCKING				
V _{DRM} , V _{RRM}	Repetitive peak off-state and Repetitive peak reverse voltages	V	3000 – 3600	T _{j min} < T _j <T _{j max} ; 180° half-sine wave; 50 Hz; Gate open
V _{DSM} , V _{RSM}	Non-repetitive peak off-state and Non-repetitive peak reverse voltages	V	3100 – 3700	T _{j min} < T _j <T _{j max} ; 180° half-sine wave; 50 Hz;single pulse; Gate open
V _D , V _R	Direct off-state and Direct reverse voltages	V	0.75·V _{DRM} 0.75·V _{RRM}	T _j =T _{j max} ; Gate open

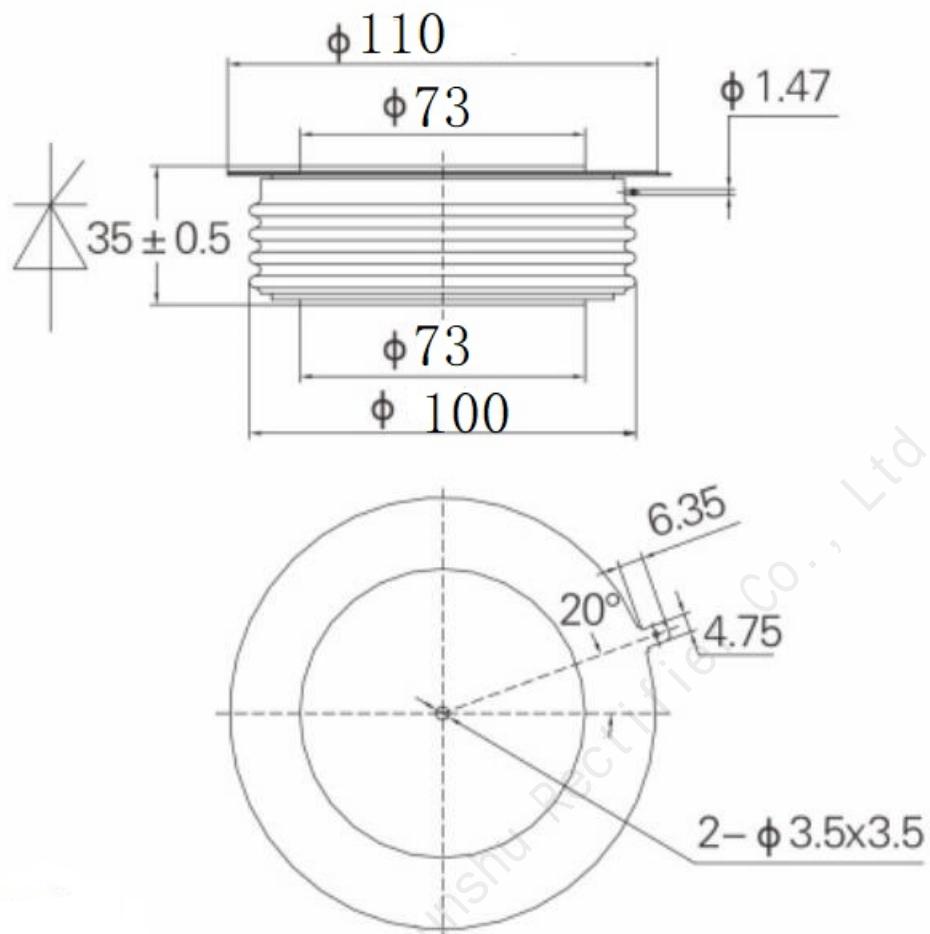
TRIGGERING				
I_{FGM}	Peak forward gate current	A	10	$T_j=T_{j \max}$
V_{RGM}	Peak reverse gate voltage	V	5	
P_G	Gate power dissipation	W	5	$T_j=T_{j \max}$ for DC gate current
SWITCHING				
$(di_T/dt)_{crit}$	Critical rate of rise of on-state current non-repetitive ($f=1$ Hz)	A/ μ s	800	$T_j=T_{j \max}; V_D=0.67V_{DRM}; I_{TM}=2 I_{TAV};$ Gate pulse: $I_G=2$ A; $t_{GP}=50$ μ s; $di_G/dt \geq 1$ A/ μ s
THERMAL				
T_{stg}	Storage temperature	°C	-60 – 125	
T_j	Operating junction temperature	°C	-60 – 125	
MECHANICAL				
F	Mounting force	kN	40.0 – 50.0	
a	Acceleration	m/s ²	50 100	Device unclamped Device clamped

CHARACTERISTICS

Symbols and parameters		Units	Values	Conditions		
ON-STATE						
V_{TM}	Peak on-state voltage, max	V	2.15	$T_j=25$ °C; $I_{TM}=5024$ A		
$V_{T(TO)}$	On-state threshold voltage, max	V	1.20	$T_j=T_{j \max};$ $0.5 \pi I_{TAV} < I_T < 1.5 \pi I_{TAV}$		
r_T	On-state slope resistance, max	$m\Omega$	0.250			
I_L	Latching current, max	mA	1500	$T_j=25$ °C; $V_D=12$ V; Gate pulse: $I_G=2$ A; $t_{GP}=50$ μ s; $di_G/dt \geq 1$ A/ μ s		
I_H	Holding current, max	mA	300	$T_j=25$ °C; $V_D=12$ V; Gate open		
BLOCKING						
I_{DRM}, I_{RRM}	Repetitive peak off-state and Repetitive peak reverse currents, max	mA	300	$T_j=T_{j \max};$ $V_D=V_{DRM}; V_R=V_{RRM}$		
$(dv_D/dt)_{crit}$	Critical rate of rise of off-state voltage ¹⁾ , min	V/ μ s	1000	$T_j=T_{j \max};$ $V_D=0.67V_{DRM};$ Gate open		
TRIGGERING						
V_{GT}	Gate trigger direct voltage, max	V	3.00 2.00	$T_j=25$ °C $T_j=T_{j \max}$	$V_D=12$ V; $I_D=3$ A; Direct gate current	
I_{GT}	Gate trigger direct current, max	mA	300 200	$T_j=25$ °C $T_j=T_{j \max}$		
V_{GD}	Gate non-trigger direct voltage, min	V	0.35	$T_j=T_{j \max};$ $V_D=0.67V_{DRM};$		
I_{GD}	Gate non-trigger direct current, min	mA	15.00	Direct gate current		
SWITCHING						
t_{gd}	Delay time	μ s	3.00	$T_j=25$ °C; $V_D=0.4V_{DRM}; I_{TM}=I_{TAV};$ Gate pulse: $I_G=2$ A; $t_{GP}=50$ μ s; $di_G/dt \geq 1$ A/ μ s		
t_q	Turn-off time ²⁾ , max	μ s	500	$dv_D/dt=50$ V/ μ s; $T_j=T_{j \max}; I_{TM}=I_{TAV};$ $di_R/dt=-10$ A/ μ s; $V_R=100$ V; $V_D=0.67V_{DRM}$		

THERMAL					
R_{thjc}	Thermal resistance, junction to case, max	$^{\circ}\text{C}/\text{W}$	0.010	Direct current	Double side cooled
R_{thjc-A}			0.022		Anode side cooled
R_{thjc-K}			0.018		Cathode side cooled
R_{thck}	Thermal resistance, case to heatsink, max	$^{\circ}\text{C}/\text{W}$	0.002	Direct current	
MECHANICAL					
W	Weight, typ	g	1700		
D_s	Surface creepage distance	mm (inch)	36.60 (1.441)		
D_a	Air strike distance	mm (inch)	16.20 (0.638)		

OVERALL DIMENSIONS



KT80DT

All dimensions in millimeters